

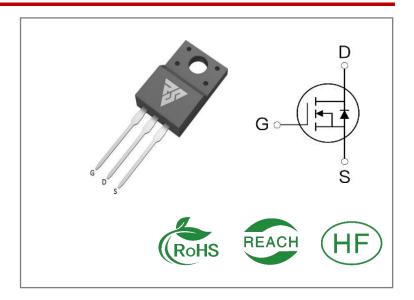
ID	R _{DS} (ON)(Typ)	VDSS
15A	0.33Ω	500V

Applications:

- Switch Mode Power Supply(SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)

Features:

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability



Ordering Information

Part Number	Package	Marking	Packing	Qty.
RS15N50F	T0-220F	RS15N50F	Tube	50 PCS

Absolute Maximun Ratings Tc= 25℃ unless otherwise specified

Symbol	Parameter	RS15N50F	Units
VDSS	Drain-to-Source Voltage	500	V
ID	Continuous Drain Current TC=25℃	15	Δ
IDM	Pulsed Drain Current (Note*1)	60	Α
PD	Power Dissipation	54	W
VGS	Gate- to- Source Voltage	±30	V
EAS	Single Pulse Avalanche Engergy L = 10mH, VDD = 50V, RG = 25 Ω	980	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	${\mathbb C}$
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

^{*} Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

Symbol	Parameter	RS15N50F	Units	Test Conditions
RθJC	Junction-to-Case	2.3	°C/W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^{\circ}\mathrm{C}$
RθJA	Junction-to- Ambient	62.5		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25℃ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	500			V	VGS=0V,ID=250μ A
IDSS	Drain- to- Source Leakage Current			1	μΑ	VDS=500V,VGS= 0V
IGSS	Gate- to- Source Forward Leakage			100	 Λ	VGS=30V ,VDS=0 V
1033	Gate- to- Source Reverse Leakage			-100	nA	VGS=-30V ,VDS= 0V

ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance(Note*2)		0.33	0.4	Ω	VGS=10V,ID=8A
VGS(TH	Gate Threshold Voltage	3		4	٧	VGS=VDS,ID=25 0μA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		33			
trise	Rise Time		8			VDS=250V
td(OFF)	Turn- OFF Delay Time		43		nS	ID=15A RG=25Ω
tfall	Fall Time		42			



Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		1785			VGS=0V
Coss	Output Capacitance		220		pF	VDS=25V
Crss	Reverse Transfer Capacitance		30			f=1.0MHz
Qg	Total Gate Charge		56			VDS=400V
Qgs	Gate- to- Source Charge		9		nC	ID=15A
Qgd	Gate-to-Drain(" Miller") Charge		28			VGS=10V

Source-Drain Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
IS	Continuous Source Current			16	Α	Integral pn- diode
ISM	Maximum Pulsed Current			64	Α	in MOSFET
VSD	Diode Forward Voltage			1.4	V	IS=8A,VGS=0V
trr	Reverse Recovery Time		490		nS	VGS=0V
Qrr	Reverse Recovery Charge		3.56		μС	IS=15A,di/dt=100 A/μs

Notes:

^{* 1.} Repetitive rating, pulse width limited by maximum junction temperature.

^{* 2.} Pulse Test: Pulse width ≤ 300μs, Duty Cycle ≤ 1%



Typical Feature Curve

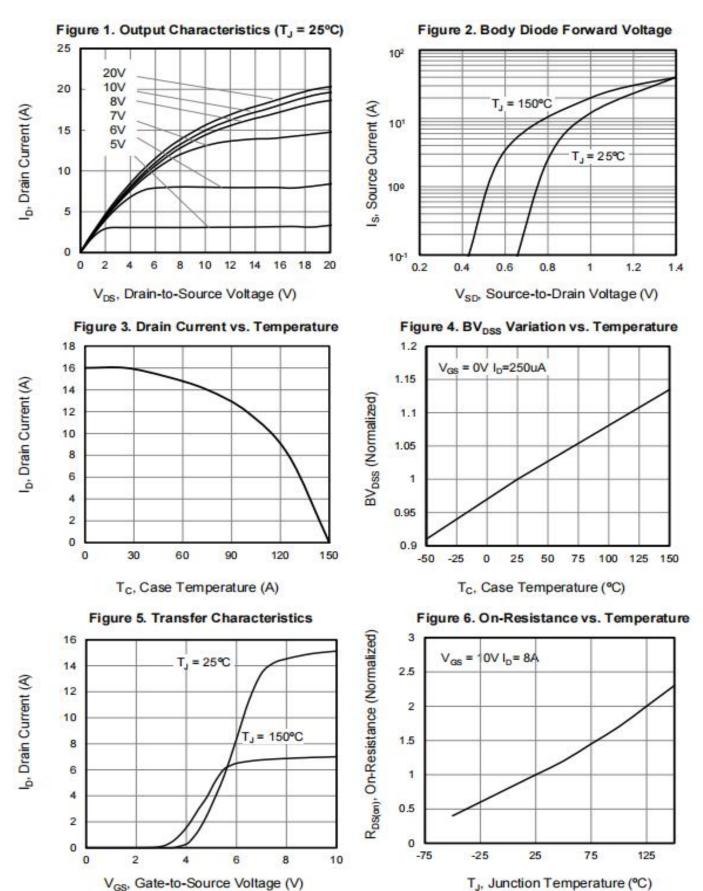
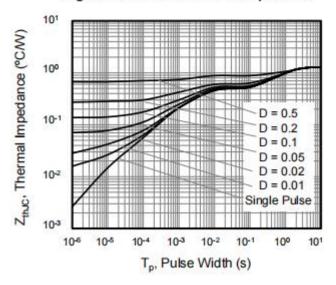


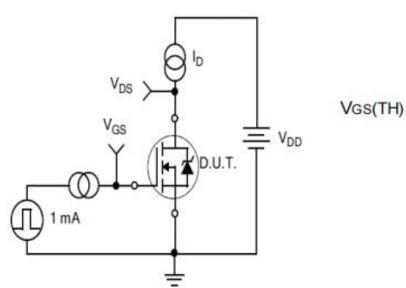


Figure 7. Capacitance 104 Capacitance (pF) Ciss 103 Coss = 102 Crss 10¹ $V_{GS} = 0V$ f = 1MHz10° 20 10 30 40 V_{DS}, Drain-to-Source Voltage (V)

Figure 9. Transient Thermal Impedance



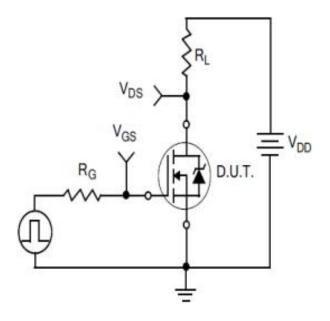
Test Circuits and Waveforms

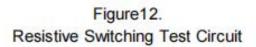


Miller Region V_{GS}

Figure10.
Gate Charge Test Circuit

Figure11.
Gate Charge Waveform





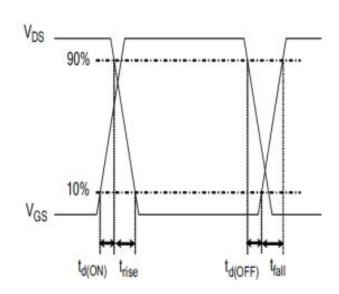


Figure 13.
Resistive Switching Waveforms

Test Circuits and Waveforms

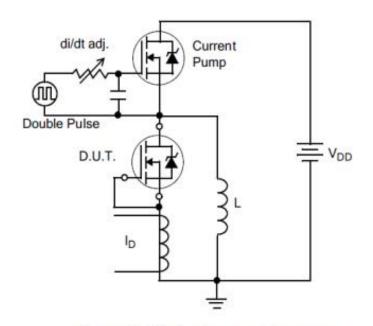


Figure 14. Diode Reverse Recovery
Test Circuit

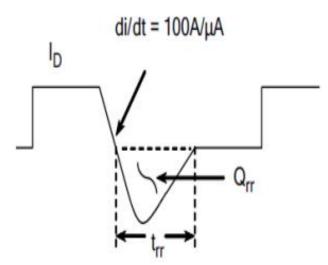


Figure 15. Diode Reverse Recovery Waveform

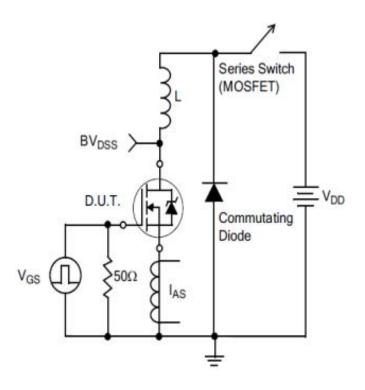
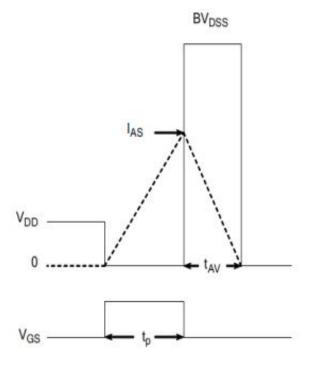
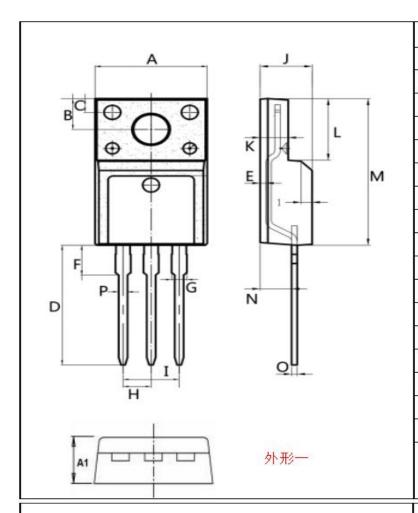


Figure 16. Unclamped Inductive Switching Test Circuit

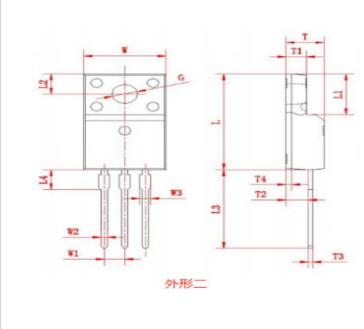




Package outline drawing(TO-220F Unit: mm)



Dim.	Min.	Max.
Α	9.95	10.36
A1	4.5	5.0
В	2.95	3.25
С	1.25	1.45
D	12.60	13.60
E	0.40	0.60
F	2.8	3.5
G	1.30	1.45
Н	(2.54	1)
1	(5.08	3)
J	4.60	4.75
K	2.45	2.65
L	6.5	6.8
М	15.4	16.0
N	2.25	3.05
0	0.45	0.55
Р	0.70	0.90



Dim.	Min.	Max.
W	9.95	10.36
W1	(2.54)	
W2	0.70	0.90
W3	1.25	1.47
L	15.67	16.07
L1	6.48	6.88
L2	3.2	3.4
L3	12.6	13.6
L4	(3.23)	
Т	4.50	4.90
T1	2.34	2.74
T2	2.25	2.95
Т3	0.45	0.60
T4	(0.	70)
G	3.08	3.28

All Dimensions in millimeter



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